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SN74LVC1G3157 SINGLE-POLE, DOUBLE-THROW ANALOG SWITCH

SCES424E - JANUARY 2003 - REVISED JUNE 2005

- 1.65-V to 5.5-V V_{CC} Operation
- Useful for Both Analog and Digital Applications
- Specified Break-Before-Make Switching

 V_{CC}

- Rail-to-Rail Signal Handling
- High Degree of Linearity

DBV PACKAGE

(TOP VIEW)

2

B2

GND

 High Speed, Typically 0.5 ns (V_{CC} = 3 V, C_L = 50 pF)

6

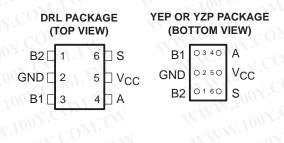
5

4

B2 1 6 S
GND 2 5 VCC
B1 3 4 A

 Low On-State Resistance, Typically ≈6 Ω (V_{CC} = 4.5 V)

- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



See mechanical drawings for dimensions.

description/ordering information

This single-pole, double-throw (SPDT) analog switch is designed for 1.65-V to 5.5-V V_{CC} operation.

The SN74LVC1G3157 can handle both analog and digital signals. The device permits signals with amplitudes of up to V_{CC} (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

ORDERING INFORMATION

T_A	PACKAGET	ORDERABLE PART NUMBER	TOP-SIDE MARKING‡		
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP		SN74LVC1G3157YEPR	TW	
-40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)	Tape and reel	SN74LVC1G3157YZPR	C5_	
10 0 10 00 0	SOT (SOT-23) – DBV	Tape and reel	SN74LVC1G3157DBVR	CC5_	
	SOT (SC-70) – DCK	Tape and reel	SN74LVC1G3157DCKR	05 (1)	
	SOT (SOT-553) – DRL	Reel of 4000	SN74LVC1G3157DRLR	- C5_	

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



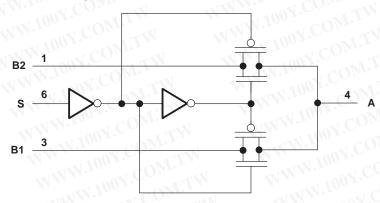
DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site. YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).

FUNCTION TABLE

CONTROL INPUT S	ON CHANNEL
L	B1
Н	B2

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC} (see Note 1)	£W	–0.5 V to 6.5 V
Control input voltage range, V _{IN} (see Notes 1 a		
Switch I/O voltage range, V _{I/O} (see Notes 1, 2,	3, and 4)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Control input clamp current, I _{IK} (V _{IN} < 0)		
I/O port diode current, I_{IOK} ($V_{I/O} < 0$ or $V_{I/O} > V$		
On-state switch current, $I_{I/O}$ ($V_{I/O} = 0$ to V_{CC}) (
Continuous current through V _{CC} or GND		
Package thermal impedance, θ_{JA} (see Note 6):		
W.100 E	DCK package	
	DRL package	142°C/W
	YEP/YZP package	123°C/W
Storage temperature range, T _{sta}		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltages are with respect to ground unless otherwise specified.
 - 2. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - This value is limited to 5.5 V maximum.
 - 4. V_I, V_O, V_A, and V_{Bn} are used to denote specific conditions for V_{I/O}.
 - 5. I_I , I_O , I_A , and I_{Bn} are used to denote specific conditions for $I_{I/O}$.
 - 6. The package thermal impedance is calculated in accordance with JESD 51-7.



SN74LVC1G3157 SINGLE-POLE, DOUBLE-THROW ANALOG SWITCH

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recommended operating conditions (see Note 7)

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MAN.	100X.CON.TW WW. 1100X	· M.TW	MIN	MAX	UNIT	
VCC	W. CON. CO. TW. WWW.	Y.Co. TW	1.65	5.5	V	
V _{I/O}	IN. TO COM.	V.COM	0	Vcc	V	
VIN	W.100 F. COM: L	COM	0	5.5	V	
Mu 100x MIN MA		V _{CC} = 1.65 V to 1.95 V	V _{CC} × 0.75			
VIH	High-level input voltage, control input	$V_{CC} = 2.3 \text{ V to } 5.5 \text{ V}$	$V_{CC} \times 0.7$	1001	V	
	TWW.10 V.COM.	V _{CC} = 1.65 V to 1.95 V	V _{CC} × 0.25		. T.T.	
V_{IL}	Low-level input voltage, control input	V _{CC} = 2.3 V to 5.5 V	WW	OV A		
	MAL TOOK ON IN	V _{CC} = 1.65 V to 1.95 V		20	OM_{ij}	
	MAN, CO. CAN MAN	V _{CC} = 2.3 V to 2.7 V	11/1/1	20	-21	
Δt/Δv	Input transition rise/fall time	V _{CC} = 3 V to 3.6 V	10		ns/V	
	M.100 COW: 1	V _{CC} = 4.5 V to 5.5 V	-31	10	1 CO $_{D}$	
TA	WILLIAM THE WAY	W.1001.	-40	85	°C	

NOTE 7: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, WWW.100Y.COM.TW Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

SN74LVC1G3157 SINGLE-POLE, DOUBLE-THROW ANALOG SWITCH

SCES424E - JANUARY 2003 - REVISED JUNE 2005

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TES	V _{CC} <	MIN TYPT	MAX	UNIT			
44	MINITON.	- 1		V _I = 0 V	I _O = 4 mA		11	20	IA.	
	1 W 100Y. COM. TW			V _I = 1.65 V	$I_O = -4 \text{ mA}$	1.65 V	-15	50	$O_{M^{*}}$	
	MM M. 100X CO.	VIII		V _I = 0 V	$I_O = 8 \text{ mA}$		8	12	Mo	
	WWW.TOOV.CO	Mr.		V _I = 2.3 V	$I_O = -8 \text{ mA}$	2.3 V	11	30		
ron	On-state switch resistance	; ‡	See Figures 1 and 2	V _I = 0 V	I _O = 24 mA		7	9	\mathbb{C}_{Ω}	
	WW. 1007.	Mo	rigules rand 2	V _I = 3 V	$I_0 = -24 \text{ mA}$	3 V	9	20	of CO	
	MM 1100X.C			V _I = 0 V	I _O = 30 mA	\mathcal{I}_{M}	6	7	1.0	
	WWW.	$C_{O_{2a}}$		V _I = 2.4 V	$I_0 = -30 \text{ mA}$	4.5 V	7	12	OXIC	
	WW.100	J CO		V _I = 4.5 V	$I_{O} = -30 \text{ mA}$		7	15	oov.	
	100		Will	VIV	$I_A = -4 \text{ mA}$	1.65 V	1	140	.00	
	On-state switch resistance		$0 \le V_{Bn} \le V_{CC}$		$I_A = -8 \text{ mA}$	2.3 V	4	45	100x	
^r range	over signal range‡§	O.Y.O	(see Figures 1 a	nd 2)	$I_A = -24 \text{ mA}$	3 V		18	Ω	
	W. Turking				$I_A = -30 \text{ mA}$	4.5 V		10	1.1	
	Difference of on-state resistance between switches‡¶#		COMIT	$V_{Bn} = 1.15 \text{ V}$	$I_A = -4 \text{ mA}$	1.65 V	0.5	-111	Ω	
			See Figure 1	V _{Bn} = 1.6V	$I_A = -8 \text{ mA}$	2.3 V	0.1	44		
Δr_{on}				V _{Bn} = 2.1 V	$I_A = -24 \text{ mA}$	3 V	0.1	11		
				V _{Bn} = 3.15 V	$I_A = -30 \text{ mA}$	4.5 V	0.1	V	MAN	
	ON resistance flatness‡¶		$0 \le V_{Bn} \le V_{CC}$ $I_A = -8 \text{ mA}$ $I_A = -24 \text{ ma}$		$I_A = -4 \text{ mA}$	1.65 V	110		TWV	
					$I_A = -8 \text{ mA}$	2.3 V	26		Ω	
ron(flat)					$I_A = -24 \text{ mA}$	3 V	9			
					$I_A = -30 \text{ mA}$	4.5 V	4		WV	
	0"		1100	M. T		1.65 V	COM	±1	44	
l _{off} *	Off-state switch leakage cu	urrent	$0 \le V_I, V_O \le V_{CC}$; (see Figure 3)		to 5.5 V	±0.05	±1 [†]	μА	
	On the second section of the second	WW	VI = VCC or GNE), TW	MM	100	Y.C.	±1		
I _{S(on)}	On-state switch leakage cu	urrent	V _O = Open (see	Figure 4)	W	5.5 V	±0.1†		μΑ	
	On attract in most assument		0.1.W.100	COM.	1	0 V to	COM	±1	_	
I _{IN}	Control input current		$0 \le V_{IN} \le V_{CC}$	WI.MOD		5.5 V	±0.05	±1 [†]	μΑ	
Icc	Supply current		V _{IN} = V _{CC} or GN	ND		5.5 V	1007	10	μΑ	
ΔlCC	Supply-current change		$V_{IN} = V_{CC} - 0.6$	A. Com	W	5.5 V	· OUN CO	500	μА	
C _{in}	Control input capacitance	S	MMM.100X.COM.		WI	5 V	2.7	OM.T		
C _{io(off)}	Switch input/output capacitance	Bn	WWW.	LTW	5 V	5.2	COM	pF		
C: / >	Switch input/output	Bn	MAL	100 Y.	WIW	E V	17.3	CON		
C _{io(on)}	1	Α				5 V	17.3	Y.C.	pF	



[‡] Measured by the voltage drop between I/O pins at the indicated current through the switch. ON resistance is determined by the lower of the voltages on the two (A or B) ports.

[§] Specified by design

 $[\]P \Delta r_{on} = r_{on(max)} - r_{on(min)}$ measured at identical V_{CC}, temperature, and voltage levels. # This parameter is characterized, but not tested in production.

Flatness is defined as the difference between the maximum and minimum values of ON resistance over the specified range of conditions.

[★]Ioff is the same as IS(off) (off-state switch leakage current).

analog switch characteristics, T_A = 25°C

PARAMETER	FROM TO TEST CONDITIONS (OUTPUT)		VCC	TYP	UNIT	
M. Took		M.Ing CON	. WW.	1.65 V	300	- XX
Frequency response	IIN MY	1207.	$R_L = 50 \Omega$,	2.3 V	300	
(switch on)†	A or Bn	Bn or A	f _{in} = sine wave (see Figure 6)	3 V	300	MHz
	W	WW.LOOV.CO	(See Figure 0)	4.5 V	300	TT
M.100	Mir	TANN TOO	ON.	1.65 V	-54	Mr.
Crosstalk	OM.TW	W V 331 100 Y.	$R_L = 50 \Omega$,	2.3 V	-54	dB
(between switches)‡	B1 or B2	B2 or B1	f _{in} = 10 MHz (sine wave) (see Figure 7)	3 V	-54	
	COMP	MMM.To	(See Figure 7)	4.5 V	-54	Oh
Feed-through attenuation	COM	INW.IOO	COM	1.65 V	-57	dB
	A or Bn	Bn or A	$C_L = 5 \text{ pF}, R_L = 50 \Omega,$	2.3 V	-57	
(switch off) [‡]			f _{in} = 10 MHz (sine wave) (see Figure 8)	3 V	-57	
	ON COMP.	MMM	(see rigule o)	4.5 V	-57	
	COM	WWW.	$C_L = 0.1 \text{ nF, } R_L = 1 \text{ M}\Omega,$	3.3 V	3	рС
Charge injection§	OOY.CS TW	Α	(see Figure 9)	5 V	7	
WWW	100Y.CO. 1TV	AM	V4 0 5 V n n D1 600 0	1.65 V	0.1	100 x
	COM.	N D NW	$V_{I} = 0.5 \text{ V p-p, R}_{L} = 600 \Omega,$ $f_{in} = 600 \text{ Hz to } 20 \text{ kHz}$	2.3 V	0.025	%
Total harmonic distortion	A or Bn	Bn or A	(sine wave)	3 V	0.015	
	100Y.	M. M.	(see Figure 10)	4.5 V	0.01	

[†]Adjust f_{in} voltage to obtain 0 dBm at output. Increase f_{in} frequency until dB meter reads –3 dB.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 5 and 11)

PARAMETER	FROM	то	V _{CC} = 1.8 V ± 0.15 V		V _{CC} = 1.8 V ± 0.15 V		V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 5 V ± 0.5 V		UNIT	
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	- *1*	
t _{pd} ¶	A or Bn	Bn or A	TIMA	2		1.2	1700 3	0.8	$V_{i,T,A}$	0.3	ns	
t _{en} #	s	Droot.C	7	24	3.5	14	2.5	7.6	1.7	5.7	20	
t _{dis}	5	Bn	3	13	2	7.5	1.5	5.3	0.8	3.8	ns	
t _{B-M} [∕]		1. 100 .	0.5	. 1	0.5	- 11	0.5	~ (I	0.5		ns	

[¶]tpd is the slower of tpLH or tpHL. The propagation delay is calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).



[‡] Adjust fin voltage to obtain 0 dBm at input.

[§] Specified by design

 $^{^{\#}}t_{en}$ is the slower of tpzL or tpzH.

Itdis is the slower of tpLZ or tpHZ.

^{*}Specified by design

PARAMETER MEASUREMENT INFORMATION

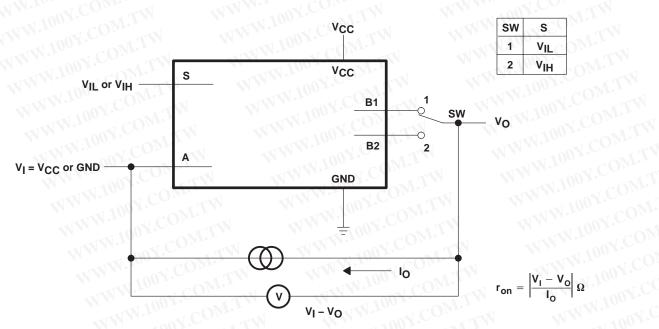


Figure 1. On-State Resistance Test Circuit

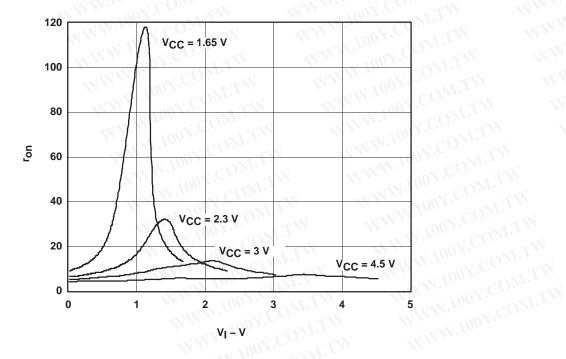
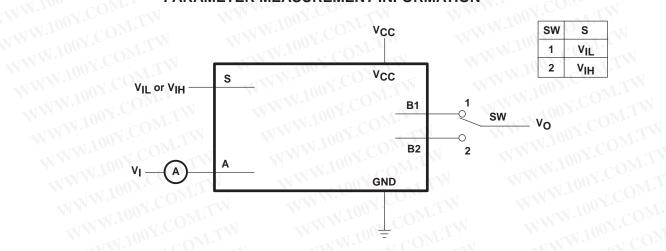


Figure 2. Typical r_{on} as a Function of Input Voltage (V_I) for $V_{I} = 0$ to V_{CC}



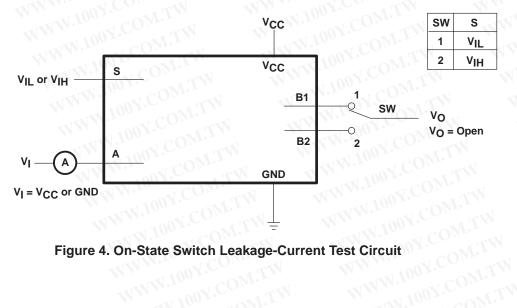
PARAMETER MEASUREMENT INFORMATION

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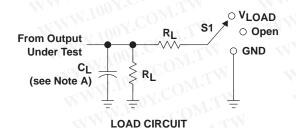
Condition 1: VI = GND, VO = VCC Condition 2: $V_I = V_{CC}$, $V_O = GND$

Figure 3. Off-State Switch Leakage-Current Test Circuit



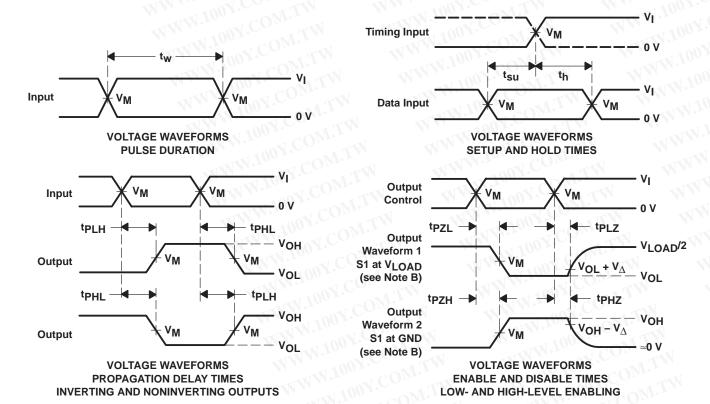
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PARAMETER MEASUREMENT INFORMATION



TEST	S1
tPLH/tPHL	Open
tPLZ/tPZL	VLOAD
tPHZ/tPZH	GND

W.100	INPUTS			11.100	COM	-51		
VCC	VI	t _r /t _f	VM	VLOAD	CL	RL	V_Δ	
$\textbf{1.8 V} \pm \textbf{0.15 V}$	VCC	≤2 ns	V _{CC} /2	2×VCC	50 pF	500 Ω	0.3 V	
2.5 V \pm 0.2 V	VCC	≤2 ns	V _{CC} /2	2×VCC	50 pF	500 Ω	0.3 V	
3.3 V \pm 0.3 V	VCC	≤2.5 ns	V _{CC} /2	2×VCC	50 pF	500 Ω	0.3 V	
5 V ± 0.5 V	VCC	≤2.5 ns	V _{CC} /2	2×VCC	50 pF	500 Ω	0.3 V	



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_{\Omega} = 50 \Omega$.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. tpLz and tpHz are the same as t_{dis}.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.
- H. All parameters and waveforms are not applicable to all devices.

Figure 5. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION

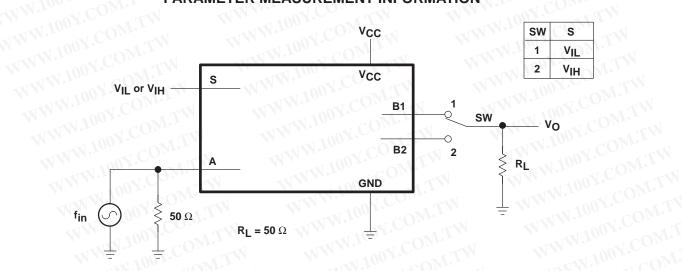


Figure 6. Frequency Response (Switch On)

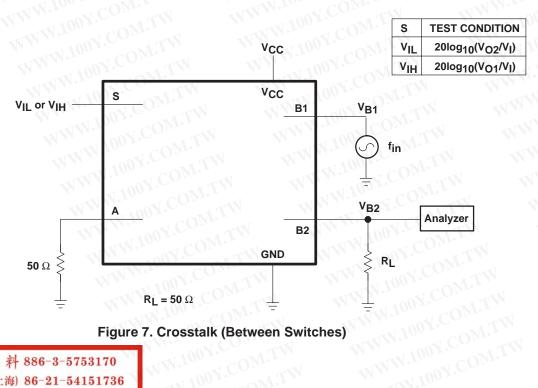


Figure 7. Crosstalk (Between Switches)

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PARAMETER MEASUREMENT INFORMATION

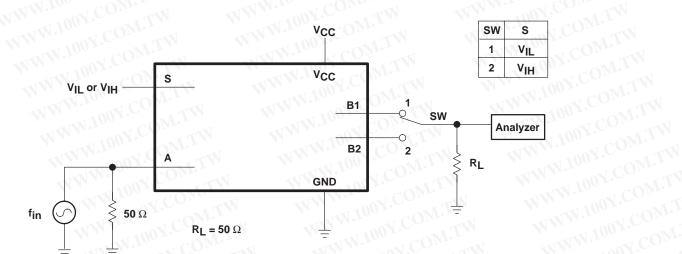


Figure 8. Feed Through

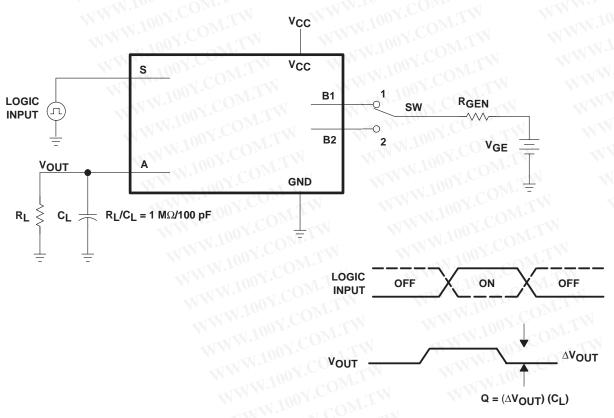


Figure 9. Charge-Injection Test

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PARAMETER MEASUREMENT INFORMATION

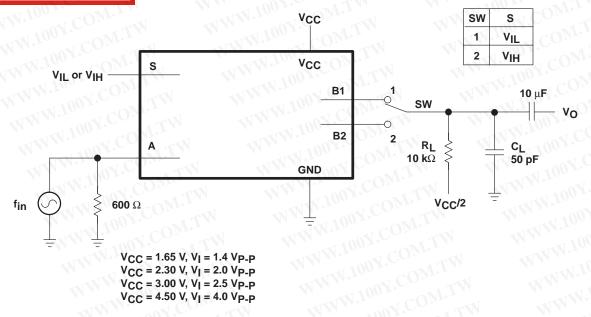


Figure 10. Total Harmonic Distortion

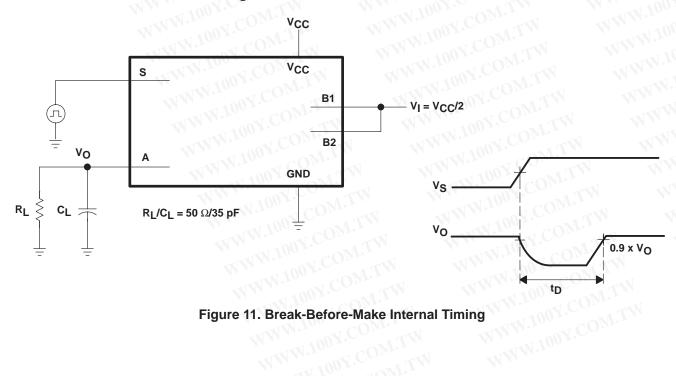


Figure 11. Break-Before-Make Internal Timing

PACKAGE OPTION ADDENDUM



18-Jul-2006

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp (3)
74LVC1G3157DBVRE4	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVC1G3157DCKRE4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVC1G3157DCKRG4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVC1G3157DRLRG4	ACTIVE	SOP	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC1G3157DBVR	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC1G3157DCKR	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC1G3157DGVR	PREVIEW	SOT-23	DBV	6	x 100	TBD	Call TI	Call TI
SN74LVC1G3157DRLR	ACTIVE	SOP	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC1G3157YEPR	NRND	WCSP	YEP	6	3000	TBD	SNPB	Level-1-260C-UNLIM
SN74LVC1G3157YZPR	ACTIVE	WCSP	YZP	6	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

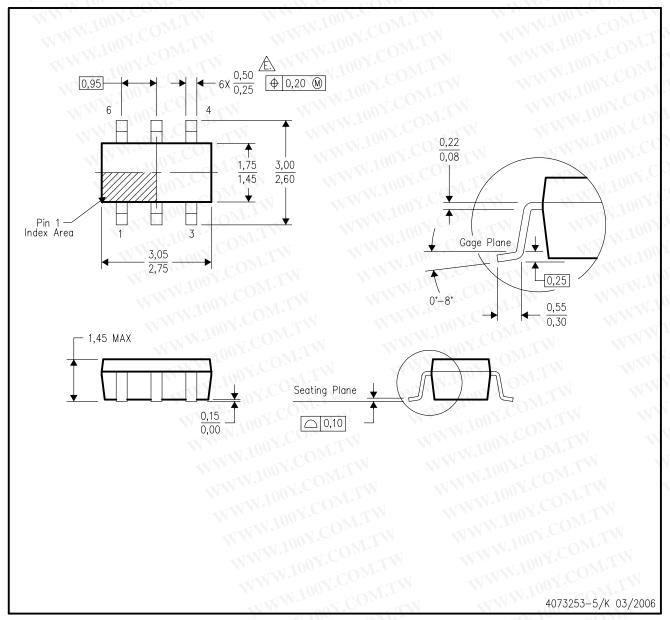
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DBV (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



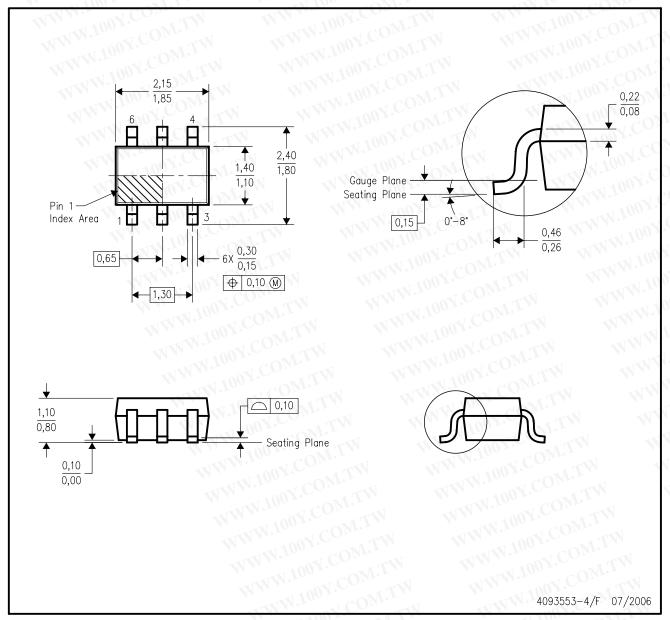
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.



DCK (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



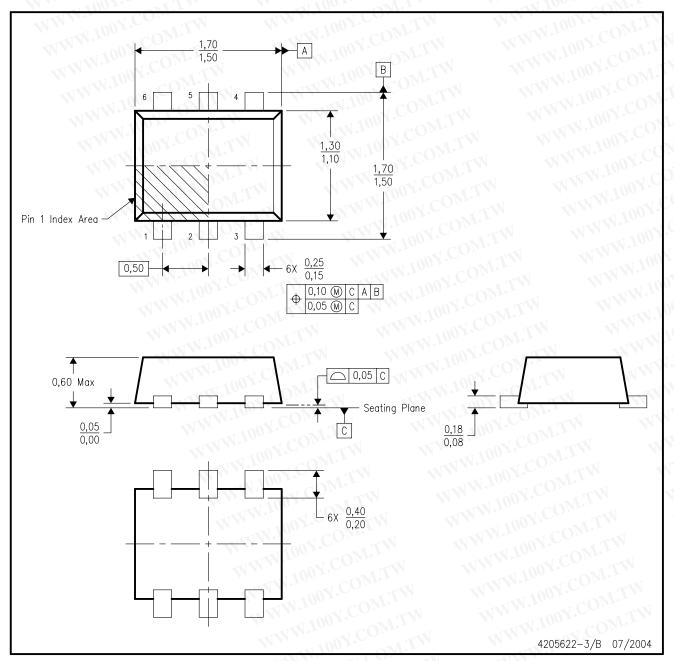
NOTES: A. All linear dimensions are in millimeters.

- 3. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



DRL (R-PDSO-N6)

PLASTIC SMALL OUTLINE



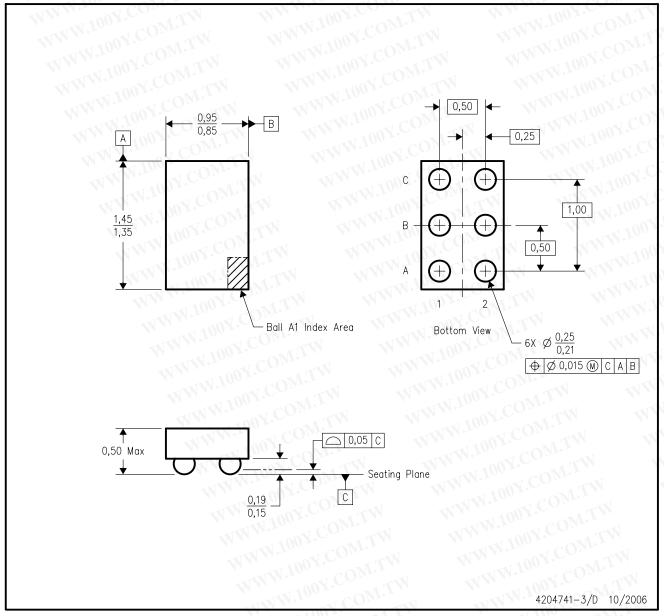
NOTES:

- All linear dimensions are in millimeters.
- WWW.100Y.COM.TW B. This drawing is subject to change without notice.
- C. JEDEC package registration is pending.



YZP (R-XBGA-N6)

DIE-SIZE BALL GRID ARRAY



- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
 - B. This drawing is subject to change without notice.
 - C. NanoFree $\ensuremath{^{\text{TM}}}$ package configuration.
 - D. This package is lead—free. Refer to the 6 YEP package (drawing 4204725) for tin—lead (SnPb).

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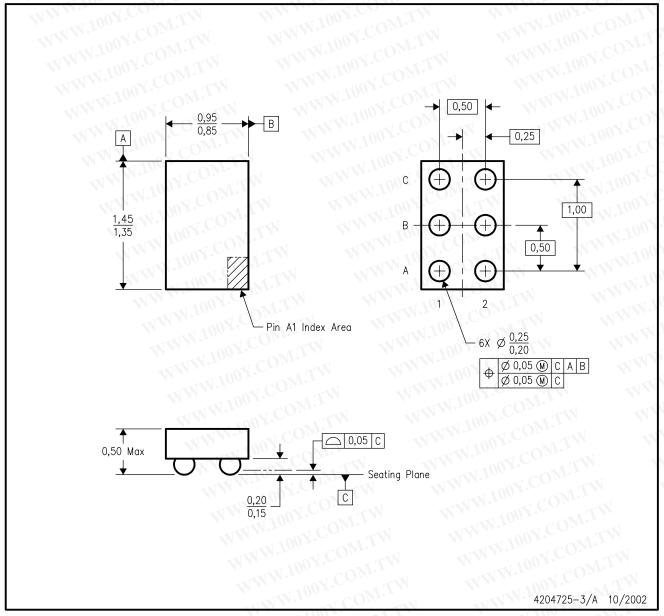
Http://www.100y.com.tw

NanoFree is a trademark of Texas Instruments.



YEP (R-XBGA-N6)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 6 YZP package (drawing 4204741) for lead-free.

NanoStar is a trademark of Texas Instruments.



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